TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74HC390AP, TC74HC390AF, TC74HC390AFN

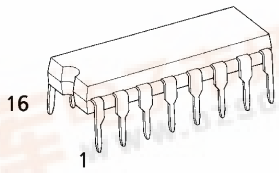
DUAL DECADE COUNTER

(Note) The JEDEC SOP (FN) is not available in Japan.

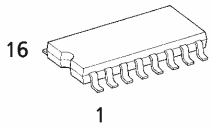
The TC74HC390A is a high speed CMOS DUAL DECADE COUNTER fabricated with silicon gate C^2MOS technology.
It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.
It consists of two independent 4 - bit counters, each composed of a divide - by - two and a divide - by - five counter. The divide - by - two counter is incremented on the negative going transition of clock A($\overline{CKA}$). The divided - by - five counter is incremented on the negative going transition of clock B($\overline{CKB}$). The counter can be cascaded to form decade, bi - quinary, or various combinations up to a divide - by - 100 counter. When the CLR input is set high, the Q outputs are set to low independent of the clock inputs.
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES :

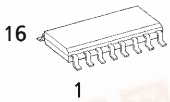
- High Speed ····· f_{MAX} = 84MHz(typ.) at V_{CC} = 5V
- Low Power Dissipation ····· I_{CC} = 4μA(Max.) at Ta = 25°C
- High Noise Immunity ····· $V_{NIH} = V_{NIL}$ = 28% V_{CC}(Min.)
- Output Drive Capability ····· 10 LSTTL Loads
- Symmetrical Output Impedance ··· $|I_{OH}| = I_{OL}$ = 4mA(Min.)
- Balanced Propagation Delays ····· $t_{pLH} \simeq t_{pHL}$
- Wide Operating Voltage Range ···· V_{CC} (opr.) = 2V ~ 6V
- Pin and Function Compatible with 74LS390



P (DIP16-P-300-2.54A)
Weight : 1.00g (Typ.)

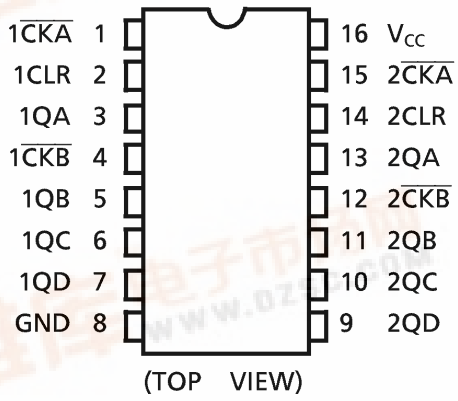


F (SOP16-P-300-1.27)
Weight : 0.18g (Typ.)

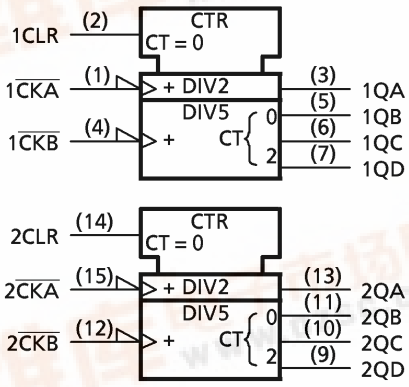


FN (SOL16-P-150-1.27)
Weight : 0.13g (Typ.)

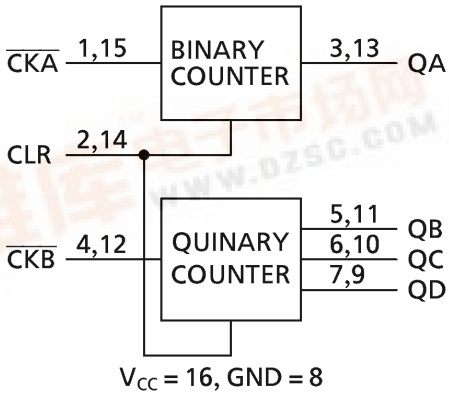
PIN ASSIGNMENT



IEC LOGIC SYMBOL



BLOCK DAIGRAM

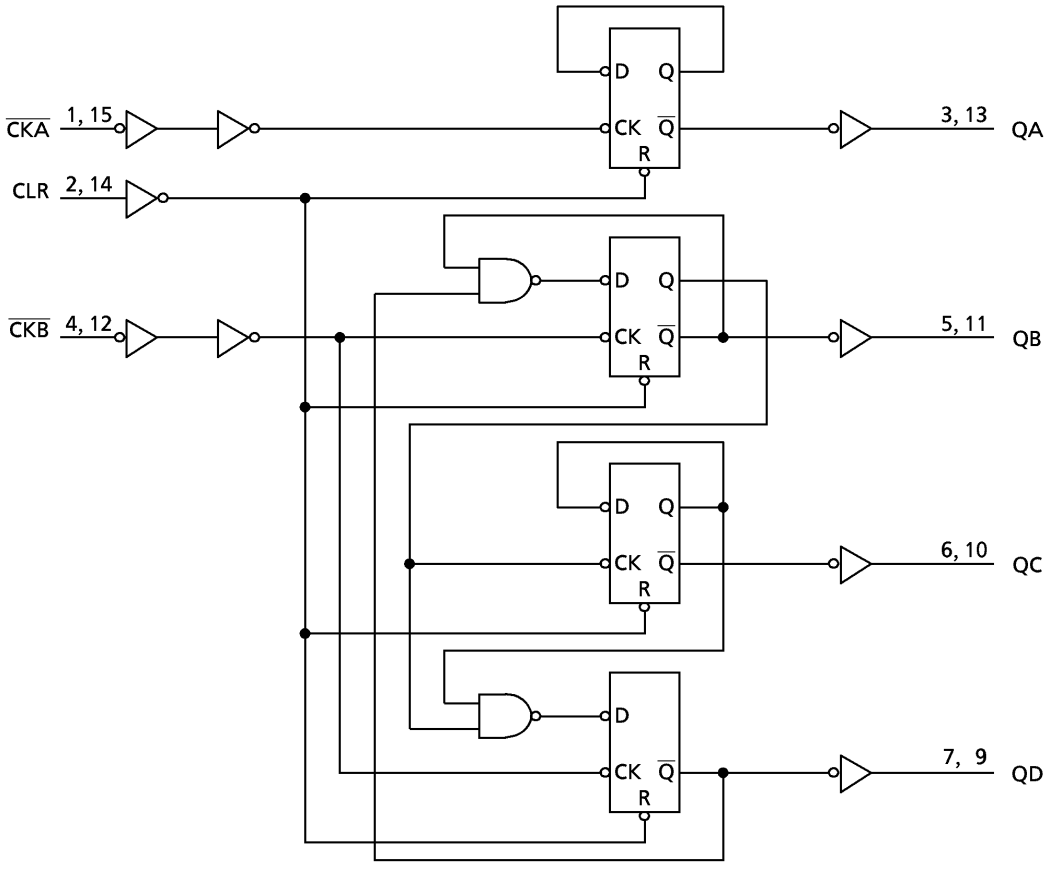


TRUTH TABLE

INPUTS			OUTPUTS			
$\overline{CKA}$	$\overline{CKB}$	CLR	QA	QB	QC	QD
X	X	H	L	L	L	L
↓	X	L	BINARY COUNT UP			
X	↓	L	QUINARY COUNT UP			

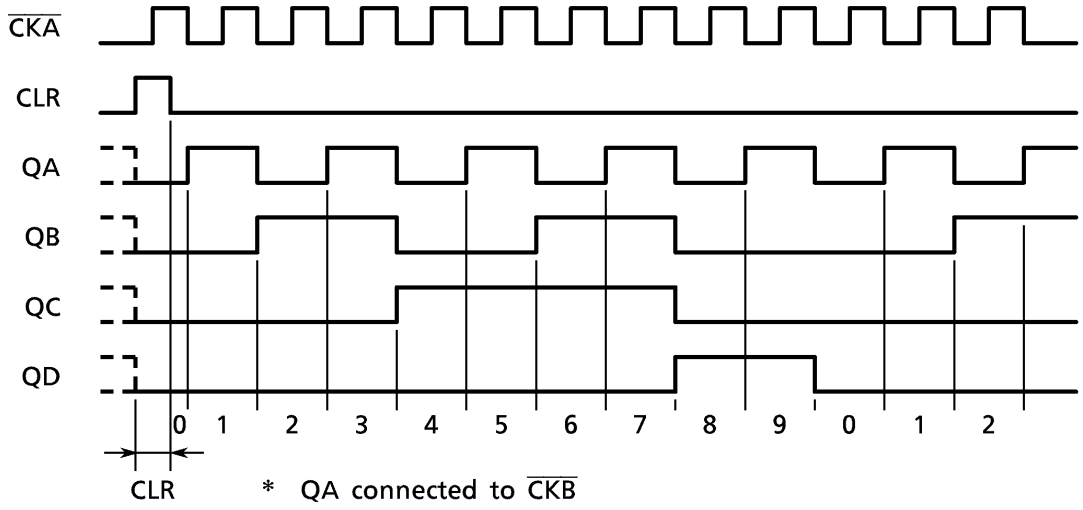
X : Don't Care

SYSTEM DIAGRAM (1/2 package)

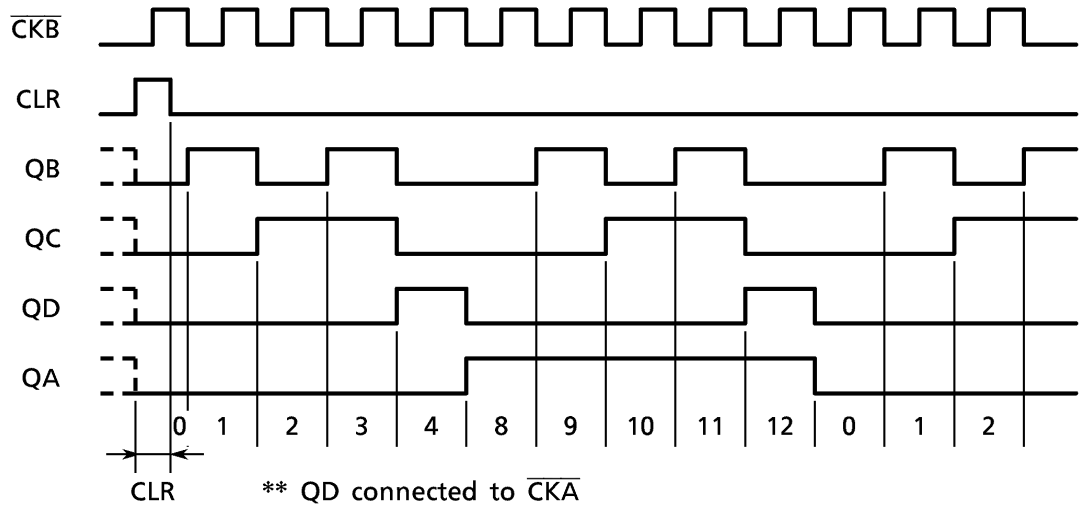


TIMING CHART

(1) BCD COUNT SEQUENCE*



(2) BI-QUINARY COUNT SEQUENCE**



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	−0.5~7	V
DC Input Voltage	V_{IN}	−0.5~V_{CC}+0.5	V
DC Output Voltage	V_{OUT}	−0.5~V_{CC}+0.5	V
Input Diode Current	I_{IK}	±20	mA
Output Diode Current	I_{OK}	±20	mA
DC Output Current	I_{OUT}	±25	mA
DC V_{CC}/Ground Current	I_{CC}	±50	mA
Power Dissipation	P_D	500 (DIP)* / 180 (SOP)	mW
Storage Temperature	T_{stg}	−65~150	°C

*500mW in the range of Ta= −40°C~65°C. From Ta=65°C to 85 °C a derating factor of −10mW/ °C shall be applied until 300mW.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	2~6	V
Input Voltage	V_{IN}	0~V_{CC}	V
Output Voltage	V_{OUT}	0~V_{CC}	V
Operating Temperature	T_{opr}	−40~85	°C
Input Rise and Fall Time	t_r, t_f	0~1000 (V_{CC}=2.0V) 0~500 (V_{CC}=4.5V) 0~400 (V_{CC}=6.0V)	ns

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		V_{CC} (V)	Ta=25°C MIN.	Ta=25°C TYP.	Ta=25°C MAX.	Ta=−40~85°C MIN.	Ta=−40~85°C MAX.	UNIT
High - Level Input Voltage	V_{IH}			2.0 4.5 6.0	1.50 3.15 4.20	− − −	− − −	1.50 3.15 4.20	− − −	V
Low - Level Input Voltage	V_{IL}			2.0 4.5 6.0	− − −	− − −	0.50 1.35 1.80	− − −	0.50 1.35 1.80	V
High - Level Output Voltage	V_{OH}	V_{IN}= V_{IH} or V_{IL}	I_{OH}=−20μA	2.0 4.5 6.0	1.9 4.4 5.9	2.0 4.5 6.0	− − −	1.9 4.4 5.9	− − −	V
			I_{OH}=−4 mA I_{OH}=−5.2mA	4.5 6.0	4.18 5.68	4.31 5.80	− −	4.13 5.63	− −	
Low - Level Output Voltage	V_{OL}	V_{IN}= V_{IH} or V_{IL}	I_{OL}=20μA	2.0 4.5 6.0	− − −	0.0 0.0 0.0	0.1 0.1 0.1	− − −	0.1 0.1 0.1	V
			I_{OL}=4 mA I_{OL}=5.2mA	4.5 6.0	− −	0.17 0.18	0.26 0.26	− −	0.33 0.33	
Input Leakage Current	I_{IN}	V_{IN}=V_{CC} or GND		6.0	−	−	±0.1	−	±1.0	μA
Quiescent Supply Current	I_{CC}	V_{IN}=V_{CC} or GND		6.0	−	−	4.0	−	40.0	

TIMING REQUIREMENTS (Input $t_r = t_f = 6ns$)

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C		Ta = −40~85°C	UNIT
			V_{CC} (V)	TYP.	LIMIT	LIMIT	
Minimum Pulse Width ($\overline{CK}$)	$t_{W(H)}$ $t_{W(L)}$		2.0	—	75	95	ns
			4.5	—	15	19	
			6.0	—	13	16	
Minimum Pulse Width (CLR)	$t_{W(H)}$		2.0	—	75	95	
			4.5	—	15	19	
			6.0	—	13	16	
Minimum Removal Time	t_{rem}		2.0	—	25	30	
			4.5	—	5	6	
			6.0	—	5	5	
Clock Frequency ($\overline{CKA}$)	f		2.0	—	6	5	MHz
			4.5	—	32	26	
			6.0	—	38	31	
Clock Frequency ($\overline{CKB}$)	f		2.0	—	6	5	
			4.5	—	31	25	
			6.0	—	36	29	

AC ELECTRICAL CHARACTERISTICS ($C_L = 15pF$, $V_{CC} = 5V$, Ta = 25°C, Input $t_r = t_f = 6ns$)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Transition Time	t_{TLH} t_{THL}		—	4	8	ns
Propagation Delay Time ($\overline{CKA}$ − QA)	t_{pLH} t_{pHL}		—	10	20	
Propagation Delay Time ($\overline{CKA}$ − QC)	t_{pLH} t_{pHL}	QA connected to $\overline{CKB}$	—	29	51	
Propagation Delay Time ($\overline{CKB}$ − QB, QD)	t_{pLH} t_{pHL}		—	12	22	
Propagation Delay Time ($\overline{CKB}$ − QC)	t_{pLH} t_{pHL}		—	17	32	
Propagation Delay Time (CLR − Qn)	t_{pHL}		—	12	26	
Maximum Clock Frequency ($\overline{CKA}$)	f_{MAX}		35	84	—	MHz
Maximum Clock Frequency ($\overline{CKB}$)	f_{MAX}		33	65	—	

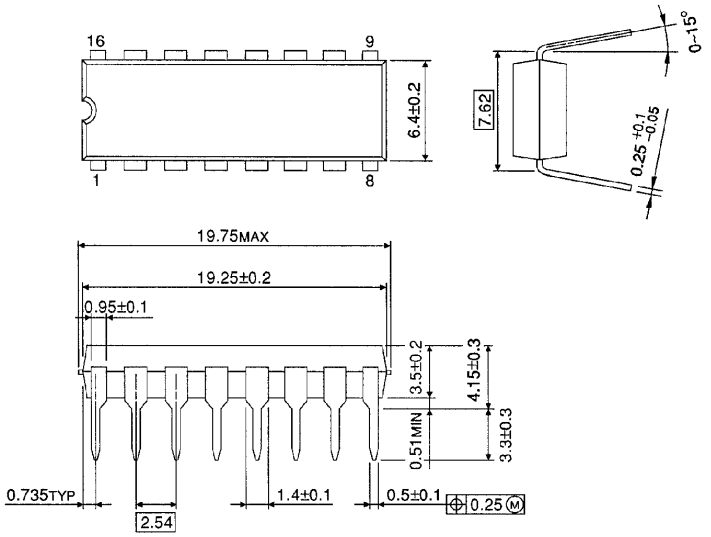
AC ELECTRICAL CHARACTERISTICS (C_L = 50pF, Input $t_r = t_f$ = 6ns)

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C			Ta = −40~85°C		UNIT
			V_{CC} (V)	MIN.	TYP.	MAX.	MIN.	MAX.	
Output Transition Time	t_{TLH} t_{THL}		2.0 4.5 6.0	— — —	30 8 7	75 15 13	— — —	95 19 16	ns
Propagation Delay Time ($\overline{CKA}$ − QA)	t_{pLH} t_{pHL}		2.0 4.5 6.0	— — —	39 13 11	120 24 20	— — —	150 30 26	
Propagation Delay Time ($\overline{CKA}$ − QC)	t_{pLH} t_{pHL}	QA connected to $\overline{CKB}$	2.0 4.5 6.0	— — —	102 34 29	290 58 49	— — —	365 73 62	
Propagation Delay Time ($\overline{CKB}$ − QB, QD)	t_{pLH} t_{pHL}		2.0 4.5 6.0	— — —	45 15 13	130 26 22	— — —	165 33 28	
Propagation Delay Time ($\overline{CKB}$ − QC)	t_{pLH} t_{pHL}		2.0 4.5 6.0	— — —	63 21 18	185 37 31	— — —	230 46 39	
Propagation Delay Time (CLR − Qn)	t_{pHL}		2.0 4.5 6.0	— — —	45 15 13	150 30 26	— — —	190 38 32	
Maximum Clock Frequency ($\overline{CKA}$)	f_{MAX}		2.0 4.5 6.0	6 32 38	20 77 90	— — —	5 26 31	— — —	MHz
Maximum Clock Frequency ($\overline{CKB}$)	f_{MAX}		2.0 4.5 6.0	6 32 36	15 60 70	— — —	5 25 29	— — —	
Input Capacitance	C_{IN}			—	5	10	—	10	pF
Power Dissipation Capacitance	C_{PD} (1)			—	44	—	—	—	

Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.
Average operating current can be obtained by the equation:

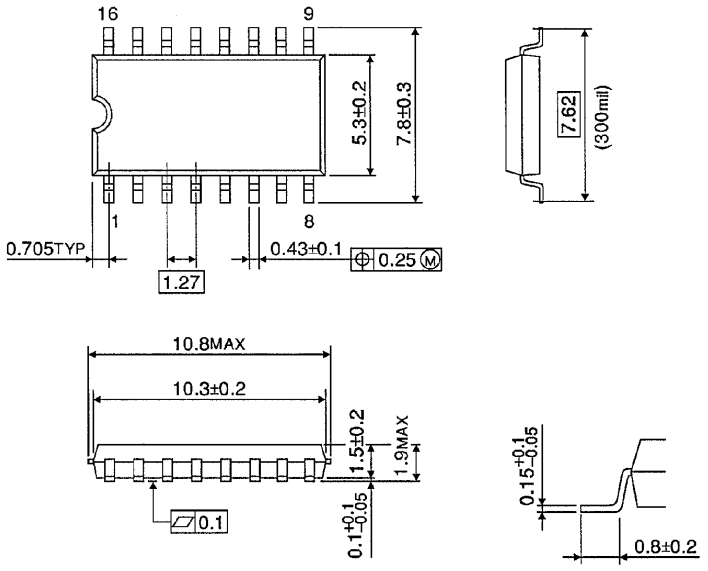
$$I_{CC}(opr) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 2 \text{ (per Counter)}$$

DIP 16PIN PACKAGE DIMENSIONS (DIP16-P-300-2.54A) Unit in mm



Weight : 1.00g (Typ.)

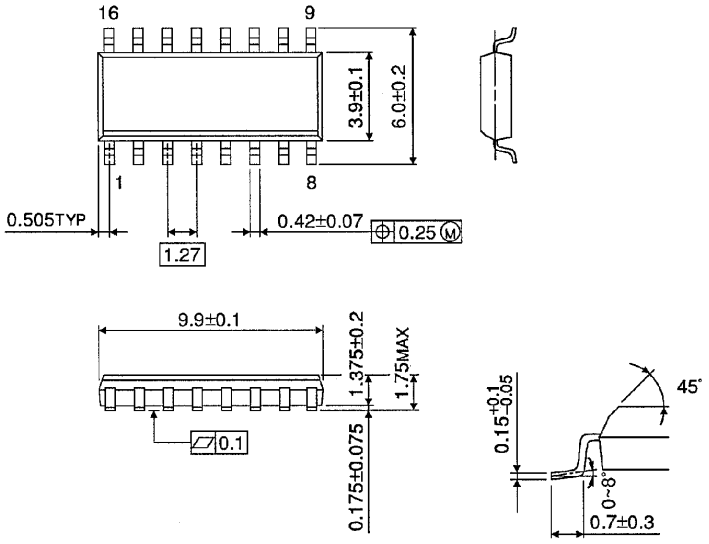
SOP 16PIN (200mil BODY) PACKAGE DIMENSIONS (SOP16-P-300-1.27) Unit in mm



Weight : 0.18g (Typ.)

SOP 16PIN (150mil BODY) PACKAGE DIMENSIONS (SOL16-P-150 -1.27) Unit in mm

(Note) This package is not available in Japan.



Weight : 0.13g (Typ.)

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